



Features

- Transient protection for high-speed data lines
IEC 61000-4-2 (ESD) $\pm 25\text{kV}$ (Air)
 $\pm 22\text{kV}$ (Contact)
- Protects one high-speed data line
- Low reverse current: $< 10\text{nA}$ typical ($V_R=5\text{V}$)
- Working voltage: 5V
- Low capacitance: 0.35pF typical
- Dynamic resistance: $0.90\ \Omega$ (Typ)
- Solid-state silicon-avalanche technology

Description

are ultra low capacitance ESD Protection devices designed to protect high speed data interfaces. They are designed to replace 0201 size multilayer varistors (MLVs) in portable applications such as cell phones, notebook, computers, and other portable electronics. This device offers desirable characteristics for board level protection including fast response time, low operating and clamping voltage, and no device degradation. has a typical capacitance of only 0.25pF . This allows it to be used on circuits operating in a 2-pin DFN0603 package. It measures $0.6 \times 0.3 \text{ mm}$ with a nominal height of only 0.25mm . Leads are finished with lead-free NiAu. Each device will protect one line operating at 5 volts. It gives the designer the flexibility to protect single lines in applications where arrays are not practical. The combination of small size and high ESD surge capability makes them ideal for use in portable applications such as cellular phones, digital cameras, and MP3 players.

Applications

- HDMI 1.3/1.4 and HDMI 2.0
- USB 2.0 and USB 3.0
- MHL
- LVDS Interfaces
- FM Antenna
- PCI Express
- eSATA Interfaces

Mechanical Characteristics

- DFN0603 package
- Pb-Free, Halogen Free, RoHS/WEEE Compliant
- Nominal Dimensions: $0.6 \times 0.3 \times 0.25 \text{ mm}$
- Lead Finish: NiAu
- Molding compound flammability rating: UL 94V-0
- Packaging: Tape and Reel

Circuit Diagram



DFN0603 Package





Absolute Maximum Rating

Rating	Symbol	Value	Units
Peak Pulse Power (tp = 8/20μs)	P _{PK}	60	Watts
Peak Pulse Current (tp = 8/ 20μs)	I _{PP}	4	A
ESD per IEC 61000-4-2 (Air) ESD per IEC 61000-4-2 (Contact)	V _{ESD}	±25 ±22	kV
Operating Temperature	T _J	-55 to +125	°C
Storage Temperature	T _{STG}	-55 to +150	°C

Electrical Characteristics (T = 25 °C)

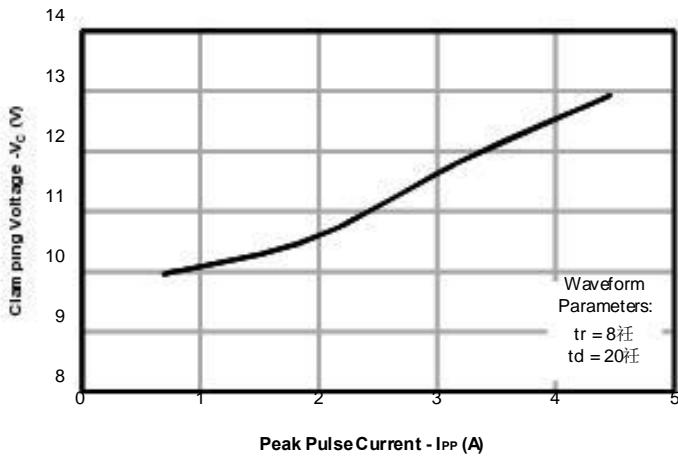
Parameter	Symbol	Conditions	Minimum	Typical	Maximum	Units
Reverse Stand-Off Voltage	V _{RWM}				5	V
Reverse Breakdown Voltage	V _{BR}	I _T =1mA	7	9	10	V
Reverse Leakage Current	I _R	V _{RWM} =5V, T=25°C			1	μA
Clamping Voltage	V _C	I _{PP} =1A, tp=8/20μs			11	V
Clamping Voltage	V _{CPP}	I=4A, tp=8/20μs			15	V
Dynamic Resistance ^{2,3,4}	R _D	tp=100ns		0.90		Ohms
Junction Capacitance	C _J	V _R =0V, f=1MHz		0.35	0.5	pF

Notes

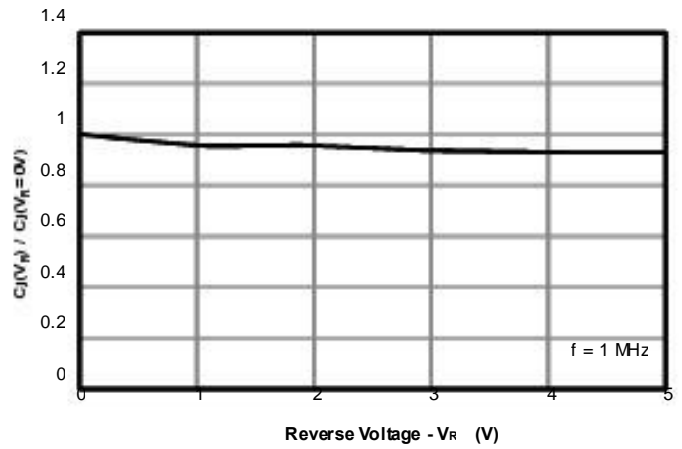
- 1)ESD gun return path connected to ESD ground reference plane.
- 2)Transmission Line Pulse Test (TLP) Settings : tp= 100ns , tr= 0.2ns , IT and VT averaging window: t1 = 70ns to t2= 90ns .
- 3) Dynamic resistance calculated from IT = 4A to IT = 16A
- 4)Guaranteed by design. Not production tested



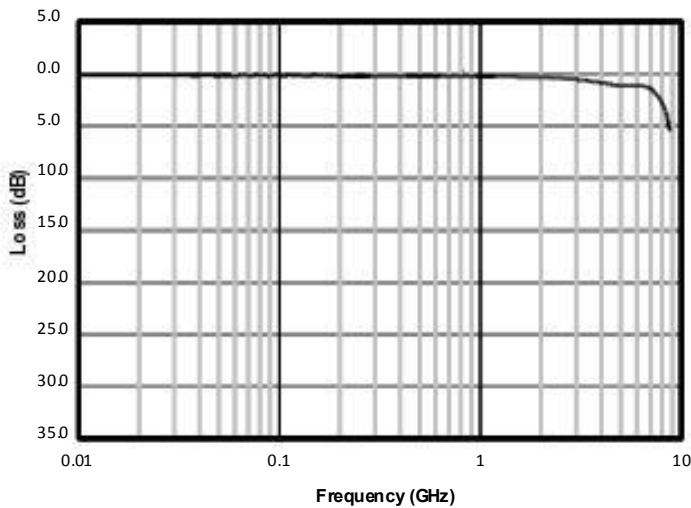
Clamping Voltage vs. Peak Pulse Current



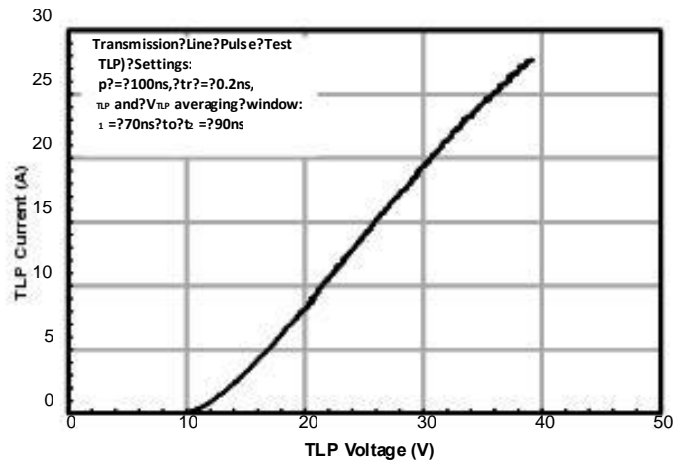
Typical Capacitance vs. Reverse Voltage



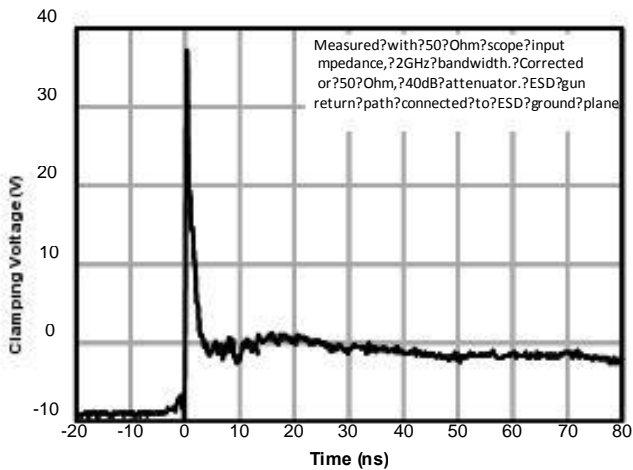
Typical Insertion Loss (S21)



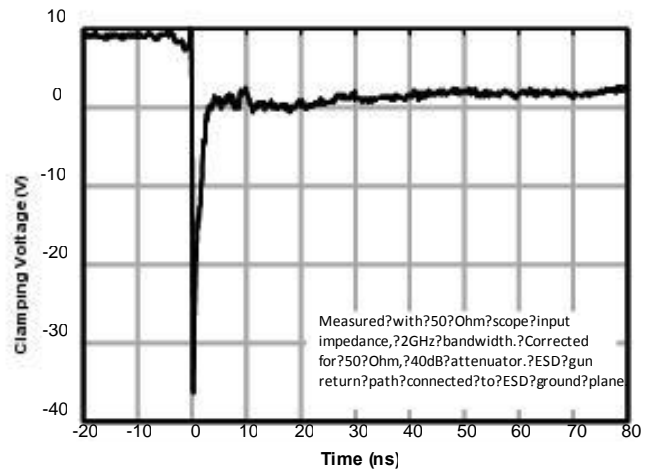
TLP Characteristic



ESD Clamping (+8kV Contact per IEC 61000-4-2)

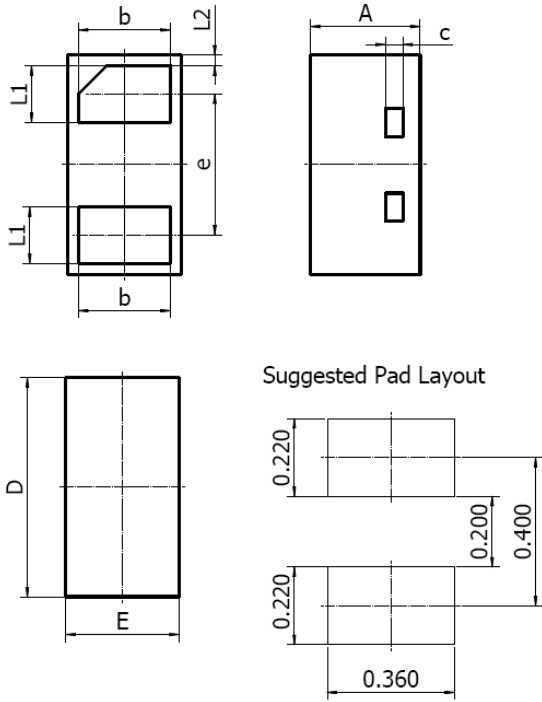


ESD Clamping (-8kV Contact per IEC 61000-4-2)





Package Outline



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	0.27	0.35	0.011	0.013
D	0.57	0.67	0.022	0.026
E	0.27	0.37	0.011	0.015
b	0.225	0.295	0.009	0.012
c	0.050REF		0.002REF	
e	0.365	0.435	0.014	0.017
L1	0.125	0.195	0.005	0.008
L2	0.030REF		0.001REF	